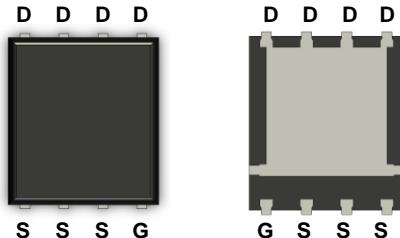


General Description

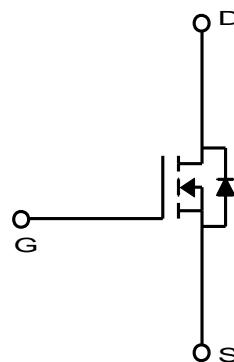
The MDU1931 uses advanced MagnaChip's MOSFET Technology, which provides high performance in on-state resistance, fast switching performance and excellent quality. MDU1931 is suitable device for Synchronous Rectification For Server and general purpose applications.

Features

- $V_{DS} = 80V$
- $I_D = 100A @ V_{GS} = 10V$
- $R_{DS(ON)} < 3.6m\Omega @ V_{GS} = 10V$
- 100% UIL Tested
- 100% R_g Tested



PDFN56



Absolute Maximum Ratings ($T_a = 25^\circ C$)

Characteristics	Symbol	Rating	Unit
Drain-Source Voltage	V_{DSS}	80	V
Gate-Source Voltage	V_{GSS}	± 20	V
Continuous Drain Current ⁽¹⁾	I_D	127.2	A
$T_c=25^\circ C$ (Silicon Limited)		100.0	
$T_c=25^\circ C$ (Package Limited)		80.5	
$T_c=100^\circ C$		20.5 ⁽³⁾	
Pulsed Drain Current	I_{DM}	400.0	
Power Dissipation	P_D	96.2	W
$T_c=25^\circ C$		38.5	
$T_c=100^\circ C$		2.5 ⁽³⁾	
Single Pulse Avalanche Energy ⁽²⁾	E_{AS}	242	mJ
Junction and Storage Temperature Range	T_J, T_{stg}	-55~150	°C

Thermal Characteristics

Characteristics	Symbol	Rating	Unit
Thermal Resistance, Junction-to-Ambient ⁽¹⁾	R_{JA}	50	°C/W
Thermal Resistance, Junction-to-Case	R_{JC}	1.3	

Ordering Information

Part Number	Temp. Range	Package	Packing	RoHS Status
MDU1931VRH	-55~150°C	PDFN56	Tape & Reel	Halogen Free

Electrical Characteristics ($T_J = 25^\circ\text{C}$)

Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	80	-	-	V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.0	-	4.0	
Drain Cut-Off Current	I_{DSS}	$V_{DS} = 72\text{V}, V_{GS} = 0\text{V}$	-	-	1.0	μA
Gate Leakage Current	I_{GS}	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$	-	-	± 0.1	
Drain-Source ON Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{V}, I_D = 50\text{A}$	-	2.9	3.6	$\text{m}\Omega$
Forward Transconductance	g_f	$V_{DS} = 10\text{V}, I_D = 50\text{A}$	-	80.0	-	S
Dynamic Characteristics						
Total Gate Charge	$Q_{g(10.0\text{V})}$	$V_{DS} = 40.0\text{V}, I_D = 50.0\text{A}, V_{GS} = 10\text{V}$	-	68.5	-	nC
Gate-Source Charge	Q_{gs}		-	18.2	-	
Gate-Drain Charge	Q_{gd}		-	15.7	-	
Input Capacitance	C_{iss}	$V_{DS} = 40.0\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$	-	4,630	-	pF
Reverse Transfer Capacitance	C_{rss}		-	40	-	
Output Capacitance	C_{oss}		-	1,050	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 10\text{V}, V_{DS} = 40.0\text{V}, I_D = 50\text{A}, R_G = 3.0\Omega$	-	19.6	-	ns
Rise Time	t_r		-	41.0	-	
Turn-Off Delay Time	$t_{d(off)}$		-	30.3	-	
Fall Time	t_f		-	18.9	-	
Gate Resistance	R_g	$f=1\text{ MHz}$	-	2.0	-	Ω
Drain-Source Body Diode Characteristics						
Source-Drain Diode Forward Voltage	V_{SD}	$I_S = 50\text{A}, V_{GS} = 0\text{V}$	-	0.80	1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = 50\text{A}, dI/dt = 100\text{A}/\mu\text{s}$	-	60.0	-	ns
Body Diode Reverse Recovery Charge	Q_{rr}		-	110.0	-	nC

Note :

1. Surface mounted FR-4 board by JEDEC (jesd51-7). Continuous current at $T_c=25^\circ\text{C}$ is silicon limited
2. E_{AS} is tested at starting $T_j = 25^\circ\text{C}$, $L = 1.0\text{mH}$, $I_{AS} = 22.0\text{A}$, $V_{GS} = 10\text{V}$.
3. $T < 10\text{sec}$.

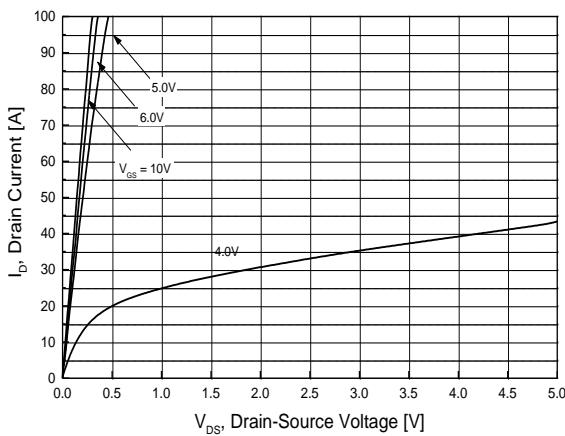


Fig.1 On-Region Characteristics

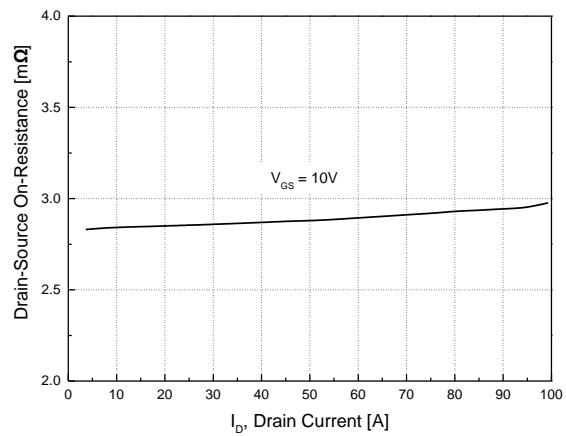


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

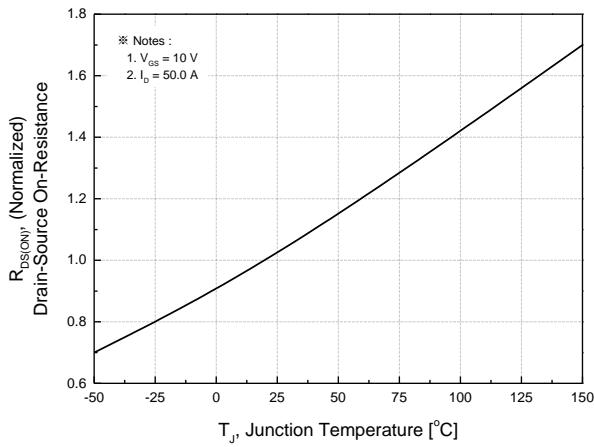


Fig.3 On-Resistance Variation with Temperature

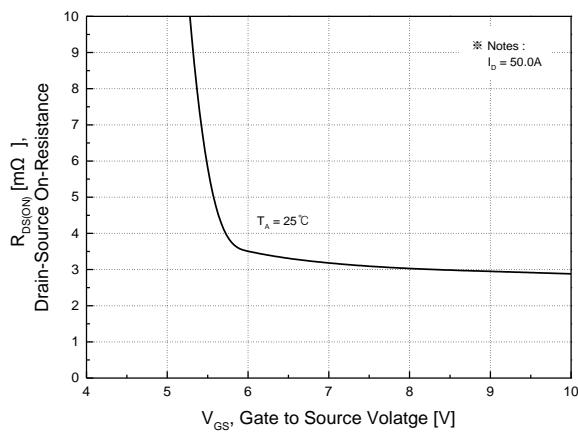


Fig.4 On-Resistance Variation with Gate to Source Voltage

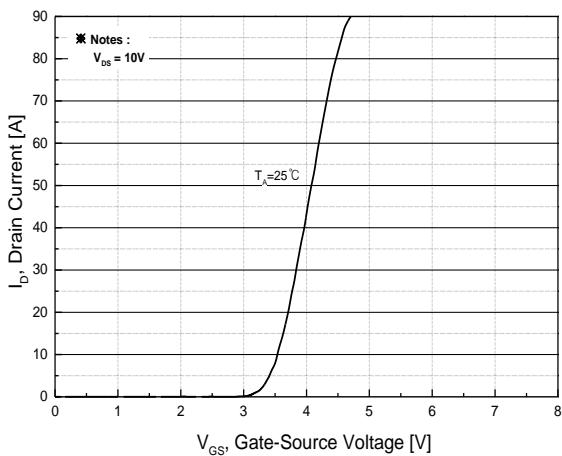


Fig.5 Transfer Characteristics

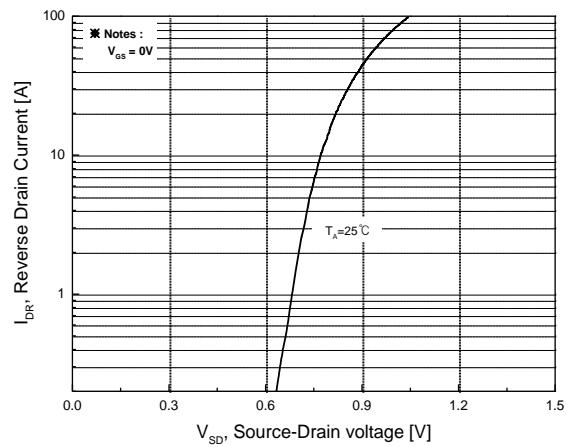


Fig.6 Body Diode Forward Voltage Variation with Source Current and Temperature

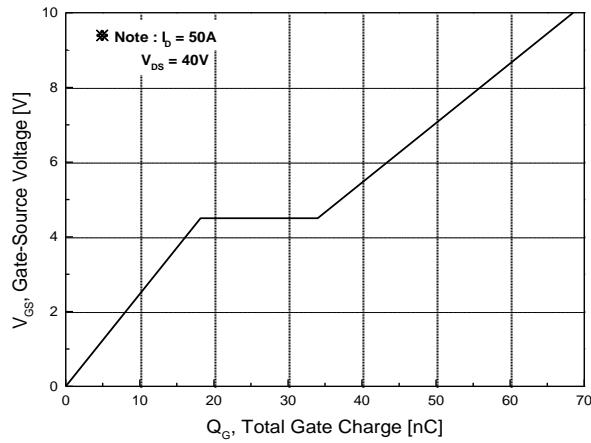


Fig.7 Gate Charge Characteristics

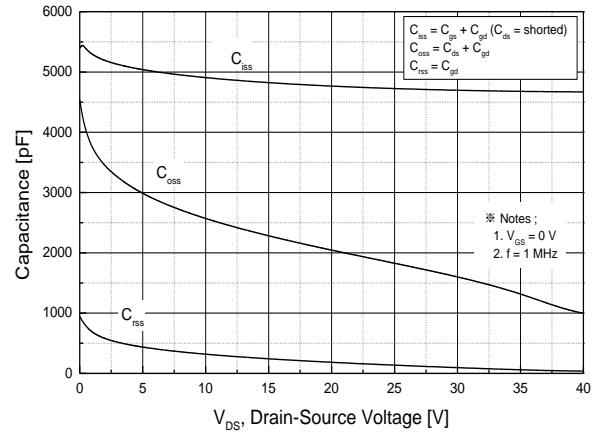


Fig.8 Capacitance Characteristics

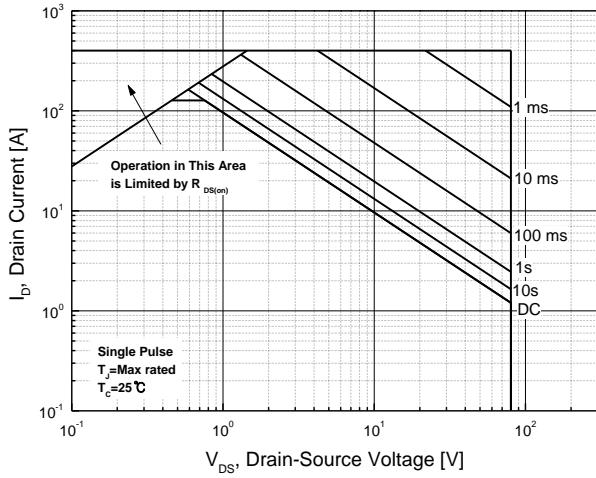


Fig.9 Maximum Safe Operating Area

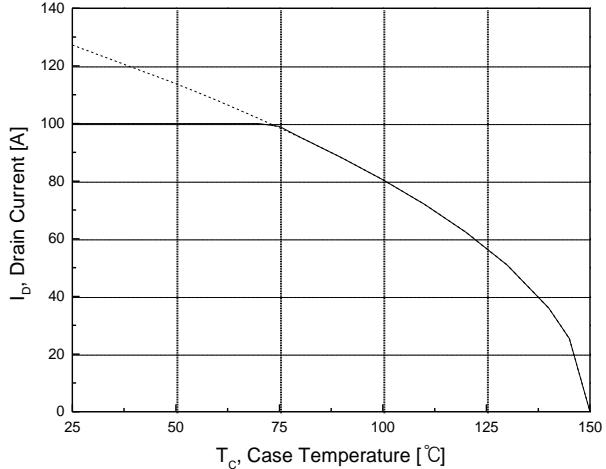


Fig.10 Maximum Drain Current vs. Case Temperature

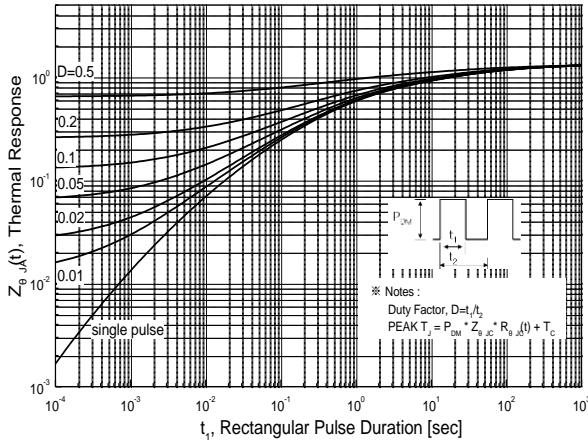
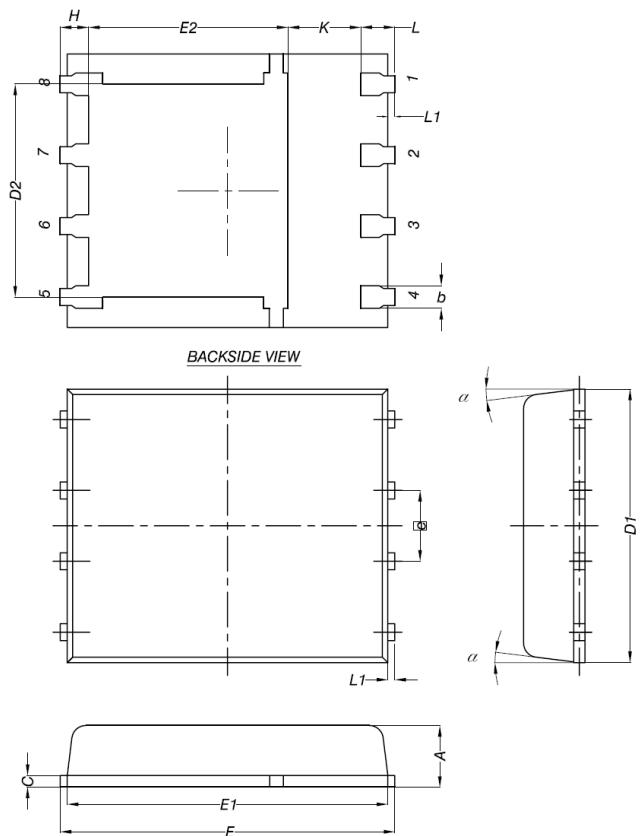


Fig.11 Transient Thermal Response Curve

Package Dimension

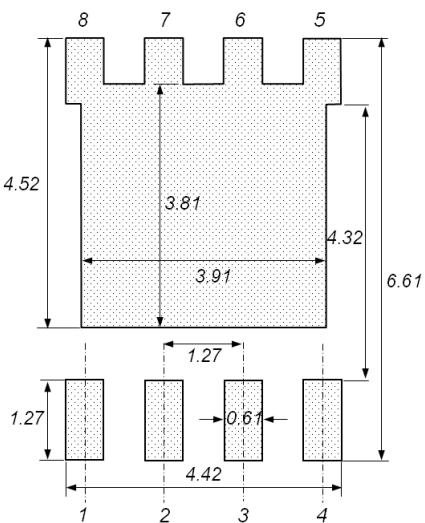
PDFN56 (5x6mm)

Dimensions are in millimeters, unless otherwise specified



Dimension	MILLIMETERS	
	Min	Max
A	0.90	1.10
b	0.33	0.51
C	0.20	0.34
D1	4.50	5.10
D2	-	4.22
E	5.90	6.30
E1	5.50	6.10
E2	-	4.30
e	1.27BSC	
H	0.41	0.71
K	0.20	-
L	0.51	0.71
α	0°	12°

Land Pattern



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